

# **Summary Statistics for TA\_LH03\_130815: Micro-CT Data Acquired at LLNL, Specimen 2 of 3**

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## Executive Summary

TA_LH03_130815				
Measured Density: 0.92 g/cm <sup>3</sup>		X-ray tube voltages (source filter materials)		
Parameter		$\mu_L$ 100 kV(Al), Al-BHC	$\mu_L$ 100 kV(Al), H <sub>2</sub> O-BHC	$\mu_H$ 160 kV (AlCu)
LAC	Mean Measured LAC (LMHU) <sup>1</sup>	1319	1306	886
	Standard Deviation/Mean	32%	28%	26%
	Entropy	7.46	7.34	6.86
<sup>L</sup> Z <sub>eff</sub>	From the mean measured LACs	7.97		
<sup>LW</sup> Z <sub>eff</sub>	From the mean measured LACs	7.31		
$\mu_L/\mu_H$	Using Al-BHC	1.49		
$\mu_L/\mu_H$	Using H <sub>2</sub> O-BHC	1.47		
QA	From Cu strip and References	See p.5		

**Table 1.** First-order statistics of the x-ray linear attenuation coefficient (LAC) in TA\_LH03\_130815, the estimated value of the effective atomic number,  $Z_{\text{eff}}$  [1] and  $\mu_L/\mu_H$ .  $Z_{\text{eff}}$  is calculated from the ratio of  $\mu_L/\mu_H$ . Beam hardening compensation has been applied to  $\mu_L$  using both aluminum (<sup>L</sup>Z<sub>eff</sub>) and water (<sup>LW</sup>Z<sub>eff</sub>) beam hardening parameters.

Using x-ray micro computed tomography (MicroCT), we have characterized the linear attenuation coefficients (LAC),  $\mu$ , of a sample of a dry powder material, tartaric acid (TA). The specimen was prepared at Lawrence Livermore National Laboratory (LLNL), loaded into a 60mL low density polyethylene (LDPE) bottle. After completed packing, the specimen was scanned following the protocol for MicroCT measurements under Test Plan 79 [2].

This particular specimen, TA\_LH03\_130815, recorded the bulk packing density (mass of sample divided by volume of sample) shown above. Two additional preparations were made and analyzed [3-4]. We used the computer program IMGREC to reconstruct the CT images. The values of the key parameters used in the x-ray data capture and image reconstruction are given in this report. Additional experimental details may be found in the SOP [5] and a separate document [6]. To characterize the statistical distribution of LAC values in each CT image, we first isolated an ~80% region or segment of volume elements (“voxels”) lying completely within the sample, away from the walls of the container. We then calculated the mean value, standard deviation and entropy for (a) the high and low energy image segments and for (b) their digital gradient images<sup>2</sup>. The statistics of the initial image of LAC values are called “first order statistics;” those of the gradient image, “second order statistics.” See Seetho [7] for details of the analysis used to obtain the numbers reported in this document.

<sup>1</sup> LMHU: “LLNL modified Hounsfield units with respect to water.” To obtain the LAC in LMHU for some material at any energy, we multiply by 1000 and divide by the LAC of water at an x-ray energy of 160 kV with aluminum and copper filters.

<sup>2</sup> A digital gradient image of a given image was obtained by taking the absolute value of the difference between the initial image and that same image offset by one voxel horizontally, parallel to the rows of the x-ray detector array.

## Summary of TA\_LH03\_130815 X-ray Statistics

Report Date: December 11, 2013

Report Prepared by: Isaac Seetho  
Typed or Printed Name

LLNL  
Organization

QA: Isaac Seetho  
Typed or Printed Name

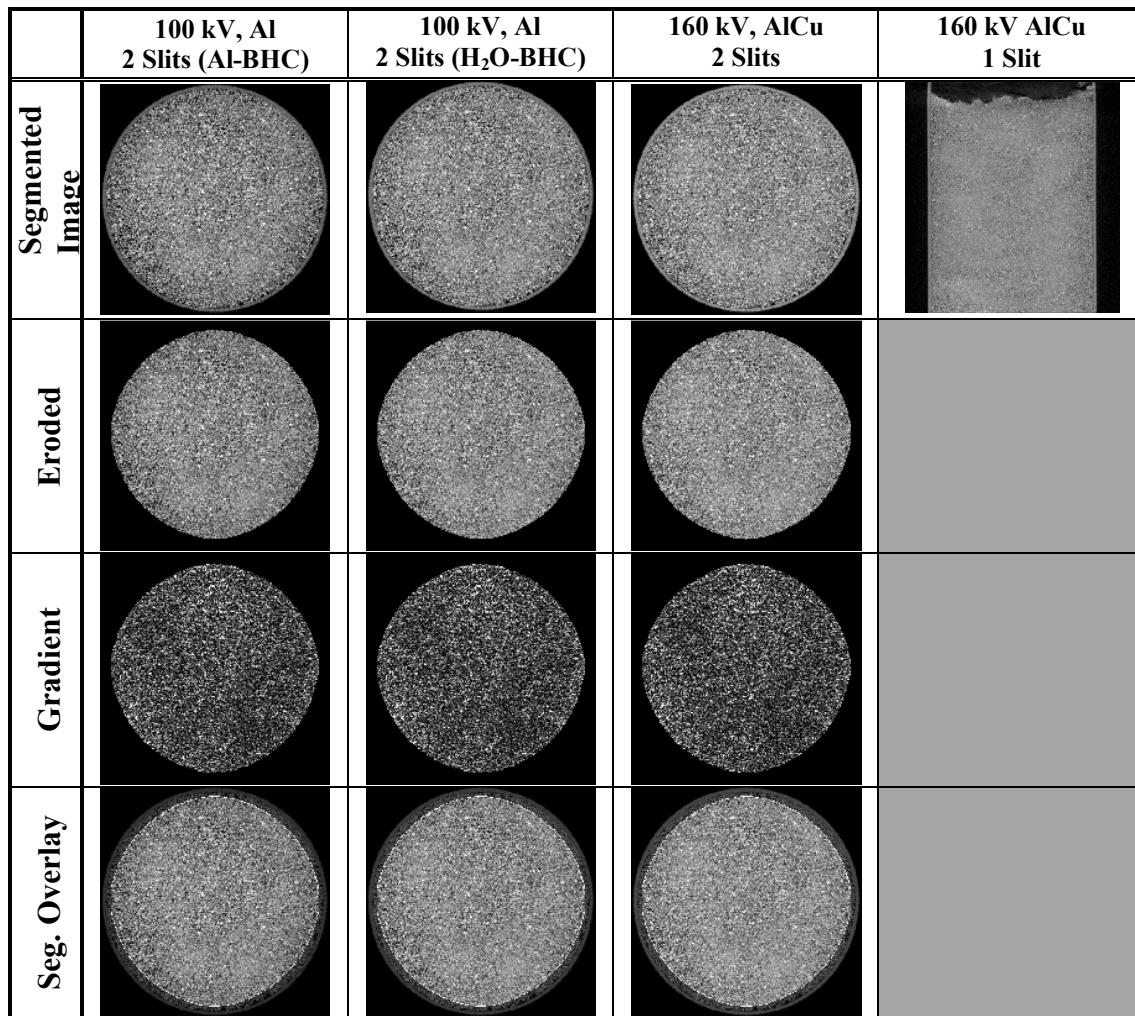
LLNL  
Organization

Material ID(s): TA\_LH03\_130815

Source			Collimator	Beam Hardening	Sample Preparation	X-ray Measurement	Linear Attenuation Coefficient (LAC)							
Bias (kV)	Filters		Number of slits	Parameter Source	Date	Date	Statistic	1 <sup>st</sup> order	2 <sup>nd</sup> order					
	Material	Thickness												
100	Al	1.943 mm	2	H <sub>2</sub> O	8/9/2013	8/15/2013	Mean	1306	259					
							Std. Dev.	372	196					
							Entropy	7.34	6.53					
100	Al	1.943 mm	2	Al	8/9/2013	8/15/2013	Mean	1319	292					
							Std. Dev.	422	220					
							Entropy	7.46	6.65					
160	Al Cu	1.943 mm 1.905 mm	2	None	8/9/2013	8/15/2013	Mean	886	161					
							Std. Dev.	231	123					
							Entropy	6.86	6.06					
<sup>L</sup> Z <sub>eff</sub>	Based on measured LAC (Al-BHC)							7.97						
<sup>LW</sup> Z <sub>eff</sub>	Based on measured LAC (H <sub>2</sub> O-BHC)							7.31						
$\mu_L/\mu_H$	Based on measured LAC (Al-BHC)							1.49						
$\mu_L/\mu_H$	Based on measured LAC (H <sub>2</sub> O-BHC)							1.47						

Table 2. Key statistics [8] for x-ray measurements of Linear Attenuation Coefficient (LAC).  ${}^L Z_{eff}$  is determined from 100 kV (Al) to 160 kV (AlCu) LAC ( $\mu_L/\mu_H$ ) as given in reference [1]. The statistics here are from the 2-slit image data (not the 1-slit open image data).

Comments: \_\_\_\_\_



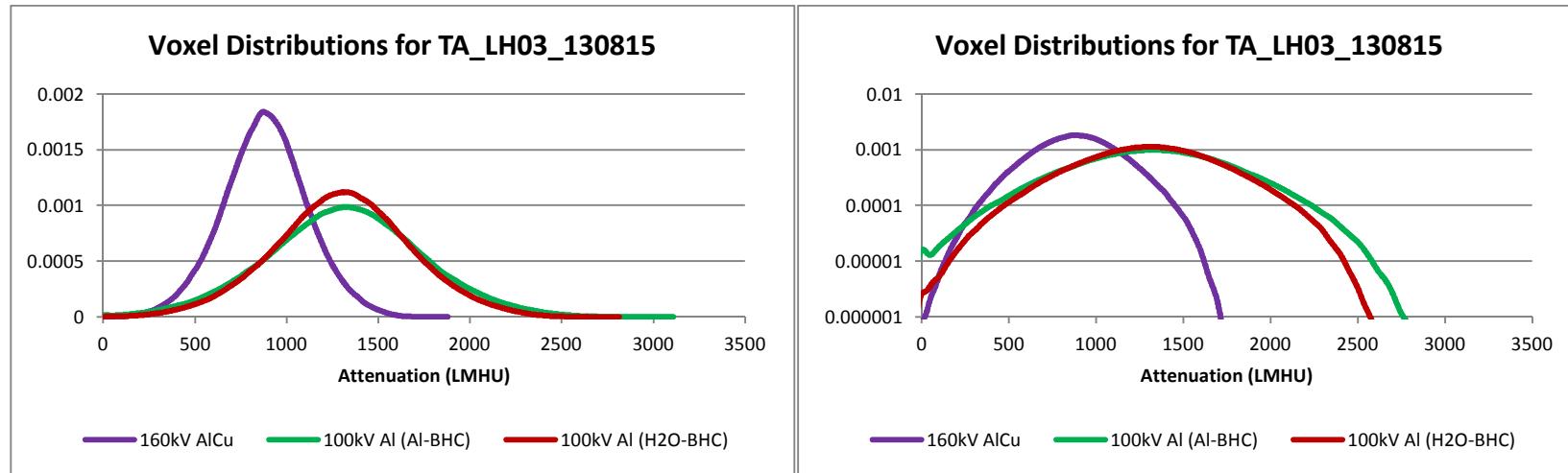
**Figure 1.** X-ray slice images with  $150\mu\text{m} \times 150\mu\text{m} \times 150\mu\text{m}$  voxels. Raw data (top row), segmented images (second row), eroded images (third row) used to calculate first order statistics. Fourth row, difference or gradient image used for second-order statistics. Images not to scale and use different gray scales to obtain maximum contrast. Single slit images (top right) are used for a qualitative visual assessment of homogeneity.

#### Comments/Observations on Appearance of Sample (texture, color, other):

The specimen displays a generally uniform granulated texture. There are pockets of material that appear to have higher density than other areas.

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## SUPPLEMENTAL ANALYSIS



**Figure 2.** KDE histograms of values of the linear attenuation coefficient (LAC) for TA\_LH03\_130815 for two x-ray source settings (linear plots – left; semi-log plots – right).

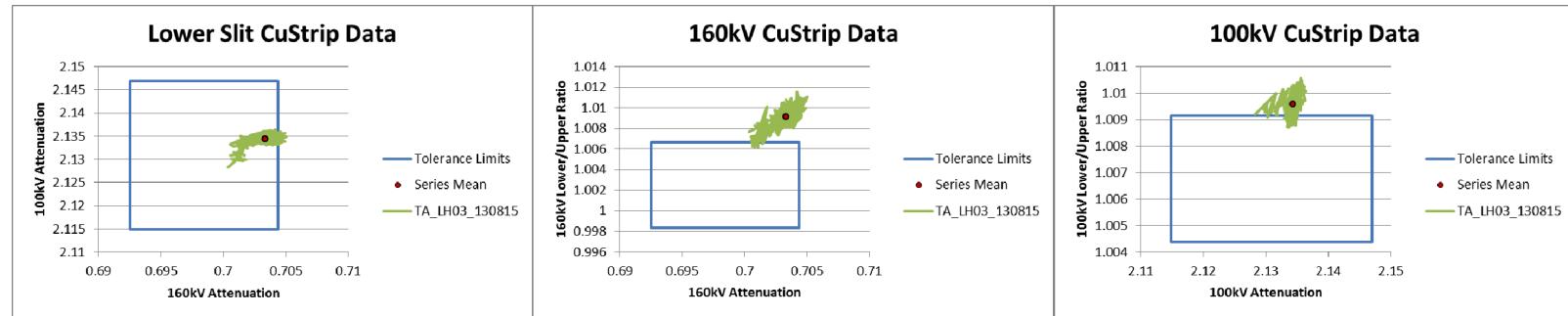
**Comments/Observations on Histograms:** These histograms are made with a Gaussian Kernel Density Estimator (KDE) [8, 9] using 150- $\mu\text{m}$  voxel upper-slit CT images.

## Reference Specimens

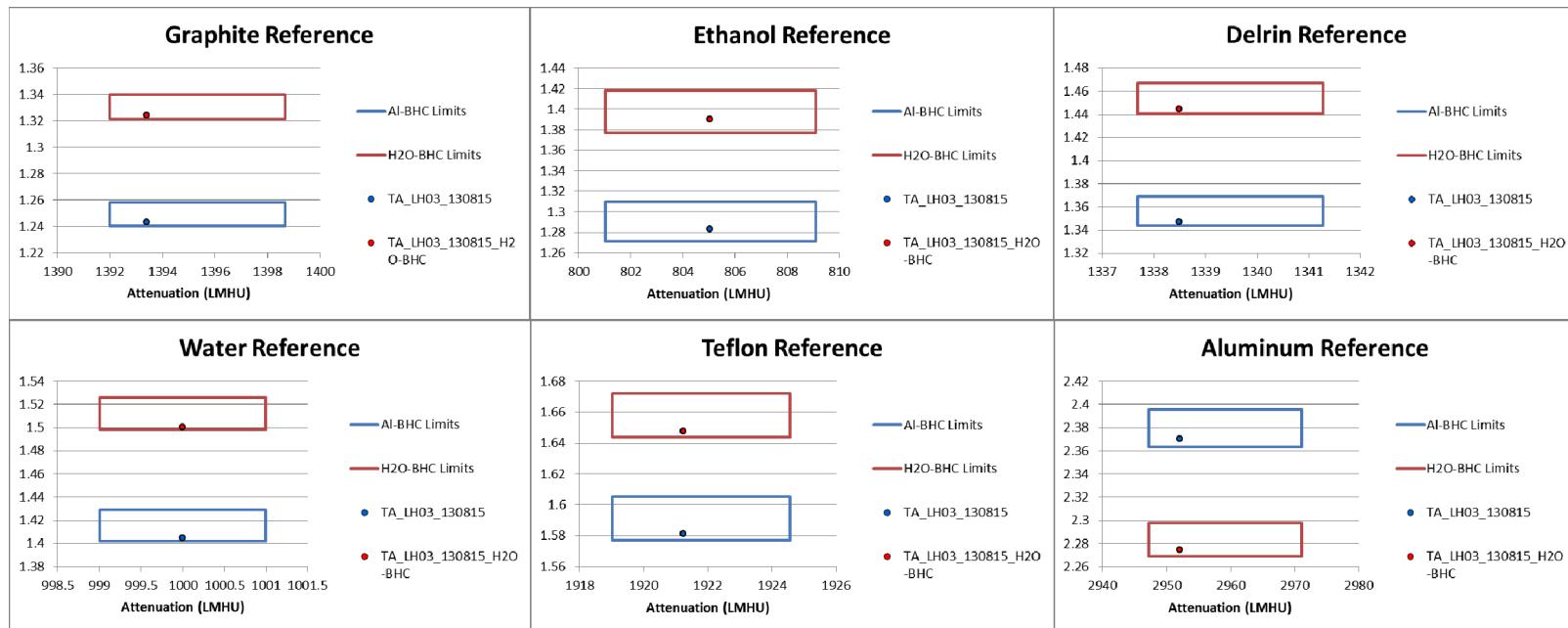
	Parameter	graphite	ethanol	Delrin*	water	Teflon**	aluminum***
<b>100kV, Al (Al-BHC)</b>	Mean (LMHU)	1732	1033	1803	1405	3038	6997
	Std Dev LMHU	81	58	81	54	89	132
<b>100kV, Al (H2O-BHC)</b>	Mean (LMHU)	1845	1119	1934	1500	3165	6714
	Std Dev LMHU	77	58	75	54	65	225
<b>160kV, AlCu</b>	Mean (LMHU)	1393	805	1338	1000	1921	2952
	Std Dev LMHU	62	47	57	48	59	74

**Table 3.** Linear attenuation coefficients of six reference materials as measured simultaneously with TA\_LH03\_130815.

\* Acetron® GP copolymer. \*\*Enflo Corp. PTFE. \*\*\*T6061 alloy.



**Figure 3.** Copper strip ratio values for both 160kV and 100kV are above limits. These tolerance limits were defined using a set of scans spanning from April through May 2013.



**Figure 4.** Reference materials are within the defined tolerance limits. These tolerance limits were defined using a set of scans spanning from April through May 2013.

## Micro-CT System Configuration

1. Scan Location Site: LLNL HEAF
2. Source: Yxlon D09 450 kV Tube; Mfr. Catalog Number: 9421-172-33503; S/N 21-5204
3. Detector: Thales Flashscan 33 with Lanex Fine Gadolinium Oxysulfate Scintillator Screen; s/n 91106194
4. Rotation control system. Controller: Newport Model ESP7000 SN: 1250
5. Carousel: LLNL 2-tray, 6" Dia.
6. Data capture computer: Dell DHM/J4271

## Micro-CT Scan Parameters

1. Scan Geometry:<sup>1</sup> SOD (mm): 1131.0 ODD (mm): 298.7  
Number of positions: 400 Angular Range: 200° Angular Increment: 0.5°
2. Number of Frames averaged per Image: 4
3. Integration time per frame: See p 7.

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<sup>1</sup> Distances are those recorded in the .sct file for this experiment and are the values used in image reconstruction.

## File Storage Locations for X-ray Data Specimen

### Root Data Path:

\Working\TP79\_IMXXXXXX\_Microstructure\_Studies\_V1\LLNL\None\HEAFCAT\None\TA\_LH03\_130815\Test\_Data\{sub directory}\

Specimen ID	Date	Radiographer	Slits	kV	mA	Al Filter (mm)	Cu Filter (mm)	Integration dpix Setting [time/frame (s)]	{sub directory}	File Name
TA_LH03_130815	130815	Morales	2	100	1.1	1.943	0	8 [2.8s]	TA_LH03_130815_100Al	TA_LH03_100Al_nn.sdt <sup>1</sup>
	130815	Morales	2	160	4.35	1.943	1.905	8 [2.8s]	TA_LH03_130815_160AlCu	TA_LH03_160AlCu_nn.sdt
	130815	Morales	1	160	4.35	1.943	1.905	8 [2.8s]	TA_LH03_130815_160AlCu1slit	TA_LH03_160AlCu1slit_nn.sdt

### Dark current, mid-range, bright field and $I_o$

### Root Data Path:

\Working\TP79\_IMXXXXXX\_Microstructure\_Studies\_V1\LLNL\None\HEAFCAT\None\TA\_LH03\_130815\Test\_Data\{sub directory}\

Slits	kV	Filter	{sub directory}	Dark Image File Name	Mid-Brightness Image File Name	Max Brightness Image File Name	$I_o$ Image File Name
2	100	Al	TA_LH03_130815_100Al	TA_LH03_100AldrkR.sdt	TA_LH03_100AlmidR.sdt	TA_LH03_100AllitR.sdt	TA_LH03_100Albak.sdt
2	160	AlCu	TA_LH03_130815_160AlCu	TA_LH03_160AlCudrkR.sdt	TA_LH03_160AlCumidR.sdt	TA_LH03_160AlCulitR.sdt	TA_LH03_160AlCubak.sdt
1	160	AlCu	TA_LH03_130815_160AlCu1slit	TA_LH03_160AlCu1slitdrkR.sdt	TA_LH03_160AlCu1slitmldR.sdt	TA_LH03_160AlCu1slitlitR.sdt	TA_LH03_160AlCu1slitbak.sdt

<sup>1</sup> nn - is the CT angular index number (0 through 399) for each individual data file

## Reconstruction

**Reconstructed by:** Kenneth E. Morales

**Date:** 8/15/2013

**Location:** LLNL

**Computer:** Dell Precision 690

### Reconstruction Software

**Software:** IMGREC

**Version:** 2.8.1.1c11

**Beam hardening compensation:** Only for 100 kV Al filtered data using Al and H<sub>2</sub>O reference materials for compensation.

### Script Files

LLNL\_script\_TA\_LH03\_100Al.txt

LLNL\_script\_TA\_LH03\_160AlCu.txt

LLNL\_script\_TA\_LH03\_160AlCu1slit\_tw\_WDB.txt

LLNL\_script\_H2OBHC\_TA\_LH03\_100Al.txt

## Reconstructed Specimen Files

### Root Data Path:

\Working\TP79\_IMXXXXXX\_Microstructure\_Studies\_V1\LLNL\None\HEAFCAT\None\TA\_LH03\_130815\Reconstruction\Recon\_130815\{sub directory}\

Slits	kV	Filter	{sub directory}	Reconstruction file name
2	100	Al	TA_LH03_130815_100Al	recobj_nn <sup>1</sup> .sdt
2	100	Al	H2O_Recon\TA_LH03_130815_100Al	recobj_nn.sdt
2	160	AlCu	TA_LH03_130815_160AlCu	recobj_nn.sdt
1	160	AlCu	TA_LH03_130815_160AlCu1slit	recry_nn.sdt , ry_nn.sdt

### Observations:

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<sup>1</sup> nn - is the index number for each reconstruction file, modified by an offset corresponding to the frame subsection extracted and analyzed.

## Analysis

**Analysis by:** Isaac Seetho

**Date:** 8/15/2013

**Location:** LLNL

**Computer:** Dell Precision T7500

### Analysis Software

**Software:** MATLAB

**Version:** R2010b

### GUI Function/Script Files

micro\_ct\_gui\_1\_3.m<sup>1</sup>

custrip\_gui\_split.m

## Reference & Specimen Analysis Files

\Working\TP79\_IMXXXXXX\_Microstructure\_Studies\_V1\LLNL\None\HEAFCAT\None\TA\_LH03\_130815\Analyses\TA\_LH03\_130815\_analysis\_IMS\_130815\

<b>Analysis File</b>	TA_LH03_130815_characterization.xlsx
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\Working\TP79\_IMXXXXXX\_Microstructure\_Studies\_V1\LLNL\None\HEAFCAT\None\TA\_LH03\_130815\Analyses\TA\_LH03\_130815\_H2O-BHC\_analysis\_IMS\_130815\

<b>Analysis File</b>	TA_LH03_130815_H2O-BHC_characterization_Corrected.xlsx
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## Copper Strip Analysis Files

### Root Data Path:

\Working\TP79\_IMXXXXXX\_Microstructure\_Studies\_V1\LLNL\None\HEAFCAT\None\TA\_LH03\_130815\Analyses\TA\_LH03\_130815\_custrip\_IMS\_130815\

<b>Aggregate Statistics</b>	Stats_TA_LH03_130815_W80xH7.xls
<b>Mean Value Time Series</b>	Custrip_TA_LH03_130815_W80xH7.xls

<sup>1</sup> Analysis using the MicroCT GUI is done according to the steps outlined in reference [7].

## REFERENCES

1. Jeffrey S. Kallman, Daniel J. Schneberk, Harry E. Martz, Jr., *Two-energy Ratio Method to Determine Zeff from Reference Materials: A Comparison of an Explosive and a Simulant*, Version 3, Lawrence Livermore National Laboratory, LLNL-TR-491153, June 24, 2011.
2. Stephen Azevedo, Jeffrey S. Kallman, Harry E. Martz, Jr., *TP79 – Microstructure Studies Using MicroCT and EDS for DHS R&D*, Lawrence Livermore National Laboratory.
3. Isaac M. Seetho, Kenn E. Morales, W. Travis White III, Harry E. Martz, Jr., *Summary Statistics for TA\_LH02\_130814: Micro-CT Data Acquired at LLNL, Specimen 1 of 3*, Lawrence Livermore National Laboratory, LLNL-TR-653599, December 11, 2013.
4. Isaac M. Seetho, Kenn E. Morales, W. Travis White III, Harry E. Martz, Jr., *Summary Statistics for TA\_LH04\_130822: Micro-CT Data Acquired at LLNL, Specimen 3 of 3*, Lawrence Livermore National Laboratory, LLNL-TR-653590, December 11, 2013.
5. “Standard Operating Procedure — Industrial Computed Tomography System Data Collection of Home-Made Explosives,” U.S. Department of Homeland Security Science and Technology Directorate, DHS/STD/TSL-xx-xx, July 9, 2009.
6. Jerel A. Smith, Daniel J. Schneberk, Jeffrey S. Kallman, Harry E. Martz, Jr., David Hoey, *Documentation of the LLNL and Tyndall Micro-Computed-Tomography Systems*, Version 091216, Lawrence Livermore National Laboratory, LLNL-TR-421377, December 17, 2009.
7. Isaac Seetho, *MicroCT: Analysis of CT Reconstructed Data of Home Made Explosive Materials Using the Matlab MicroCT Analysis GUI*, Lawrence Livermore National Laboratory, IDD-MCT-SOP-007, January 13, 2011.
8. Harry E. Martz, Jr., and Carl Crawford, *Validation of Explosive Simulants Requirement Specification*, Version 12, Lawrence Livermore National Laboratory, LLNL-TR-416983-REV 1, October 26, 2009.
9. B. W. Silverman, *Density Estimation*, Chapman and Hall, 1986.